Unit in mm

TOSHIBA TRANSISTOR SILICON NPN TRIPLE DIFFUSED TYPE

2 S C 5 3 5 4

HIGH SPEED AND HIGH VOLTAGE SWITCHING APPLICATIONS SWITCHING REGULATOR APPLICATIONS HIGH SPEED DC-DC CONVERTER APPLICATIONS

Excellent Switching Times : $t_r = 0.7 \mu s \, (Max.)$

 $t_f = 0.5 \mu s \, (Max.) \, (I_C = 2A)$

High Collector Breakdown Voltage: VCEO=800V

MAXIMUM RATINGS (Ta = 25°C)

CHARACTERIS	SYMBOL	RATING	UNIT		
Collector-Base Voltage	v_{CBO}	900	V		
Collector-Emitter Voltag	v_{CEO}	800	V		
Emitter-Base Voltage	v_{EBO}	7	V		
Collector Current	DC	$I_{\mathbf{C}}$	5	A	
	Pulse	I_{CP}	10		
Base Current	$I_{\mathbf{B}}$	2	Α		
Collector Power Dissipation		$P_{\mathbf{C}}$	100	W	
$(Tc = 25^{\circ}C)$	10	100			
Junction Temperature	T_{j}	150	°C		
Storage Temperature Range		$ m T_{stg}$	-55~150	$^{\circ}\mathrm{C}$	

15.9 MAX. $Ø3.2 \pm 0.2$ 2.0 ± 0.3 + 0.3 1.0 = 0.25 5.45 ± 0.2 5.45 ± 0.2 +0.3 -0.1 1. BASE 2. COLLECTOR (HEAT SINK) 3. EMITTER

Weight: 4.7g (Typ.)

2-16C1A

JEDEC EIAJ TOSHIBA

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ELECTRICAL CHARACTERISTICS (Ta = 25°C)

CHARACTERISTIC S		SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT	
Collector Cut-off Current		I_{CBO}	$V_{CB} = 800V, I_{E} = 0$	_	_	100	μA	
Emitter Cut-off Current		I_{EBO}	$V_{EB}=7V, I_{C}=0$	_	_	1	mA	
Collector-Base Breakdown Voltage			$I_C=1$ mA, $I_E=0$	900	_	_	V	
Collector-Emitter Breakdown Voltage		V (BR) CEO	$I_{\rm C} = 10 {\rm mA}, \ I_{\rm B} = 0$	800	_	_	V	
DC Current Gain		h _{FE} (1)	$V_{CE}=5V, I_{C}=10mA$	10	_	_		
		h _{FE} (2)	$V_{CE}=5V$, $I_{C}=0.5A$	15		_		
Collector-Emitter Saturation Voltage		V _{CE (sat)}	$I_{C}=2A, I_{B}=0.4A$	_	_	1.0	V	
Base-Emitter Saturation Voltage		V _{BE} (sat)	$I_{C}=2A, I_{B}=0.4A$	_	_	1.3	V	
Switching Time	Rise Time	$t_{ m r}$	$I_{B1} = 0.4A INPUT I_{B2} = -0.8A DUTY CYCLE \leq 1\%$	_	_	0.7	μs	
	Storage Time	$t_{ ext{stg}}$		_	_	4.0		
	Fall Time	tf		_	_	0.5		